

**Notice of References Cited**

Application/Control No.

10/003,234

Applicant(s)/Patent Under  
Reexamination  
ANMA, MASATOSHI

Examiner

A. Sefer

Art Unit

2826

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,936,297	08-1999	Jun	257/530
	B	US-6,492,206	12-2002	Hawley et al	438/131
	C	US-6,489,197	12-2002	Uchiyama	438/253
	D	US-5,166,556	11-1992	Hsu et al	307/465
	E	US-6,107,165	08-2000	Jain et al	438/467
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 6-50824	02-1994	Japan	Hasegawa	
	O	JP 5-215567	09-1993	Japan	Murayama	
	P	JP 2000-49230	02-2000	Japan	Domae et al	
	Q	JP 7-22513	01-1995	Japan	Takagi et al	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.